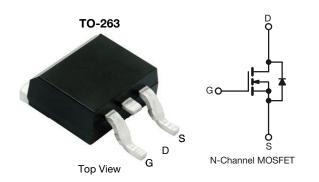


## IPB107N20NA-VB Datasheet N-Channel 200 V (D-S) 175 °C MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	200			
$R_{DS(on)}$ Typ. ( $\Omega$ ) at $V_{GS} = 10 \text{ V}$	0.0076			
$R_{DS(on)}$ Typ. ( $\Omega$ ) at $V_{GS} = 7.5 \text{ V}$	0.0086			
Q <sub>g</sub> typ. (nC)	58			
I <sub>D</sub> (A)	100			
Configuration	Single			



#### **FEATURES**

- Thunder power MOSFET
- Maximum 175 °C junction temperature
- 100 % R<sub>g</sub> and UIS tested



#### **APPLICATIONS**

- Power supplies:
  - Uninterruptible power supplies
  - AC/DC switch-mode power supplies
  - Lighting
- Synchronous rectification
- DC/DC converter
- Motor drive switch
- DC/AC inverter
- Solar micro inverter
- Class D audio amplifier

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>A</sub> = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V <sub>DS</sub>	200	V	
Gate-source voltage		V <sub>GS</sub>	± 20	v	
Continuous drain current	T <sub>C</sub> = 25 °C	I <sub>D</sub>	100		
	T <sub>C</sub> = 125 °C		62		
Pulsed drain current (t = 100 μs)		I <sub>DM</sub>	300	А	
Continuous source-drain diode current		I <sub>S</sub>	100		
Single pulse avalanche current <sup>a</sup>	L = 0.1 mH	I <sub>AS</sub>	60		
Single pulse avalanche energy <sup>a</sup>	L = U.1 IIII	E <sub>AS</sub>	180	mJ	
Maximum power dissipation	T <sub>C</sub> = 25 °C	P <sub>D</sub>	375 <sup>b</sup>	10/	
	T <sub>C</sub> = 125 °C		125 <sup>b</sup>	W	
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	00	
Soldering recommendations (peak temperature) <sup>c</sup>			260	°C	

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	MAXIMUM	UNIT	
Maximum junction-to-ambient (PCB mount) <sup>c</sup>		R <sub>thJA</sub>	40	°C/W	
Maximum junction-to-case (drain)	Steady state	R <sub>thJC</sub>	0.4	] 0/11	

#### Notes

- a. Duty cycle ≤ 1 %.
- b. See SOA curve for voltage derating.
- c. When mounted on 1" square PCB (FR4 material).
- d. Package limited.



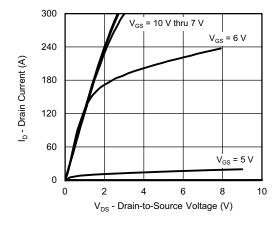
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	200	-	-	V	
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = 250 \ \mu A$	2	-	4	V	
Gate-source leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	250	nA	
Zero gate voltage drain current	I <sub>DSS</sub>	$V_{DS} = 200 \text{ V}, V_{GS} = 0 \text{ V}$	=.	-	1	Δ	
		V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	150	μA	
		V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 175 °C	-	-	5	mA	
On-state drain current a	I <sub>D(on)</sub>	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	60	-	=.	Α	
Drain-source on-state resistance a	Б	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 40 A	-	0.0076	-	Ω	
	$R_{DS(on)}$	$V_{GS} = 7.5 \text{ V}, I_D = 40 \text{ A}$	-	0.0086	-		
Forward transconductance a	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 40 A	-	63	-	S	
Dynamic <sup>b</sup>							
Input capacitance	C <sub>iss</sub>		=.	3120	=.	pF	
Output capacitance	C <sub>oss</sub>	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	=.	280	=.		
Reverse transfer capacitance	C <sub>rss</sub>		=.	24	-		
Total gate charge	Qg		-	58	87	nC	
Gate-source charge	$Q_{gs}$	$V_{DS} = 100 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 60 \text{ A}$	-	17.6	-		
Gate-drain charge	Q <sub>gd</sub>		-	17.2	-		
Output charge	Q <sub>oss</sub>	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$	=.	108	162		
Gate resistance	$R_g$	f = 1 MHz	1.5	3	5	Ω	
Turn-on delay time	t <sub>d(on)</sub>		-	14	28	- ns	
Rise time	t <sub>r</sub>	$\begin{split} V_{DD} = 100 \text{ V, } R_L = 1.66  \Omega \text{, } I_D \cong 60 \text{ A,} \\ V_{GEN} = 10 \text{ V, } R_g = 1  \Omega \end{split}$	-	125	250		
Turn-off delay time	t <sub>d(off)</sub>		=.	27	54		
Fall time	t <sub>f</sub>		=.	80	150		
<b>Drain-Source Body Diode Characteristic</b>	s						
Pulse diode forward current (t = 100 μs)	I <sub>SM</sub>		-	-	240	Α	
Body diode voltage	$V_{SD}$	$I_F = 30 \text{ A}, V_{GS} = 0 \text{ V}$	-	0.85	1.5	V	
Body diode reverse recovery time	t <sub>rr</sub>		-	150	300	ns	
Body diode reverse recovery charge	Q <sub>rr</sub>	L = 20 A dl/dt = 100 A/::a	-	0.9	1.8	nC	
Reverse recovery fall time	ta	I <sub>F</sub> = 30 A, dl/dt = 100 A/μs	-	125	-	20	
Reverse recovery rise time	t <sub>b</sub>		-	25	-	ns	
Body diode peak reverse recovery charge	I <sub>RM(REC)</sub>		-	11.5	20	Α	

#### Notes

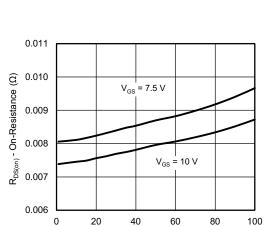
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



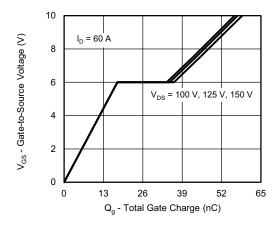


**Output Characteristics** 

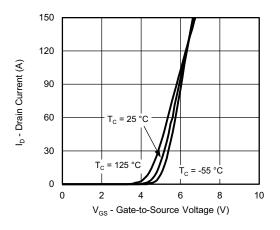


On-Resistance vs. Drain Current and Gate Voltage

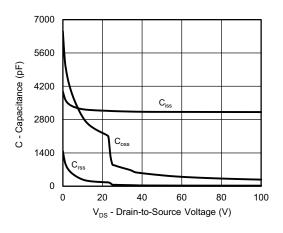
I<sub>D</sub> - Drain Current (A)



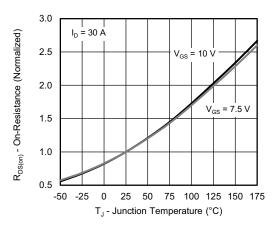
**Gate Charge** 



**Transfer Characteristics** 

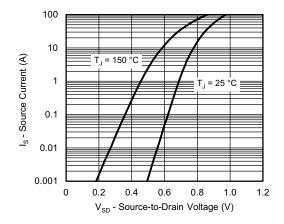


Capacitance

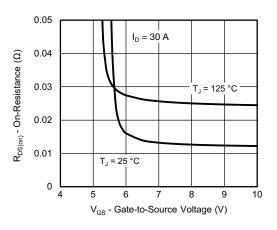


On-Resistance vs. Junction Temperature

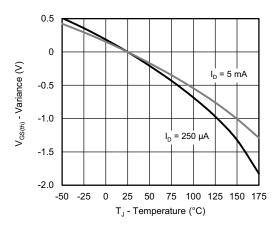




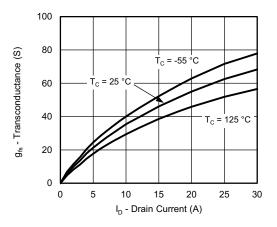
Source-Drain Diode Forward Voltage



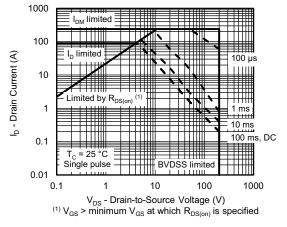
On-Resistance vs. Gate-to-Source Voltage



**Threshold Voltage** 

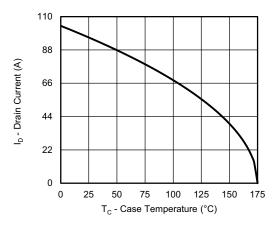


Transconductance

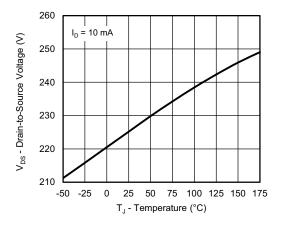


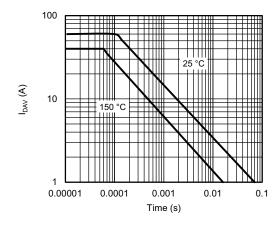
Safe Operating Area, Junction-to-Ambient





## Current Derating a





Drain Source Breakdown vs. Junction Temperature

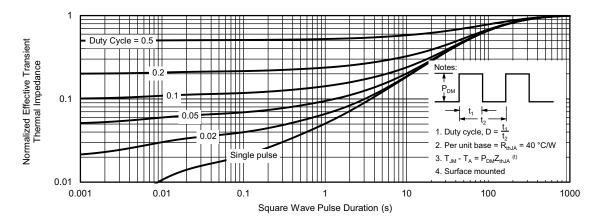
I<sub>DAV</sub> vs. Time

#### Note

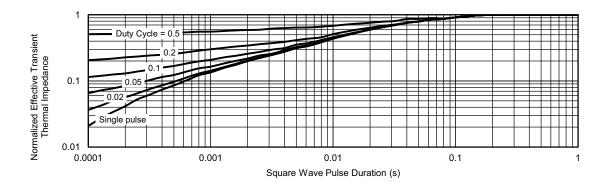
a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 25 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

服务热线:400-655-8788 5





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



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